

Solar Probe Plus

A NASA Mission to Touch the Sun



Integrated Science Investigation of the Sun Energetic Particles

Preliminary Design Review

05 – 06 NOV 2013

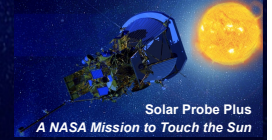
EPI-Lo Mechanical



*Scott Cooper
Steve Layman
Shaughn London*



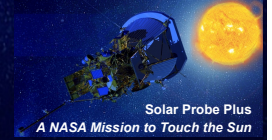
Outline



- Summary of mechanical design requirements
- Overview of mechanical design
- Detailed description of the instrument mechanical design
 - Wedge Assembly
 - MCP Assembly
 - SSD Assembly
- Assembly process
- Mechanical development status
- Summary of analyses
- Summary of Peer Review results



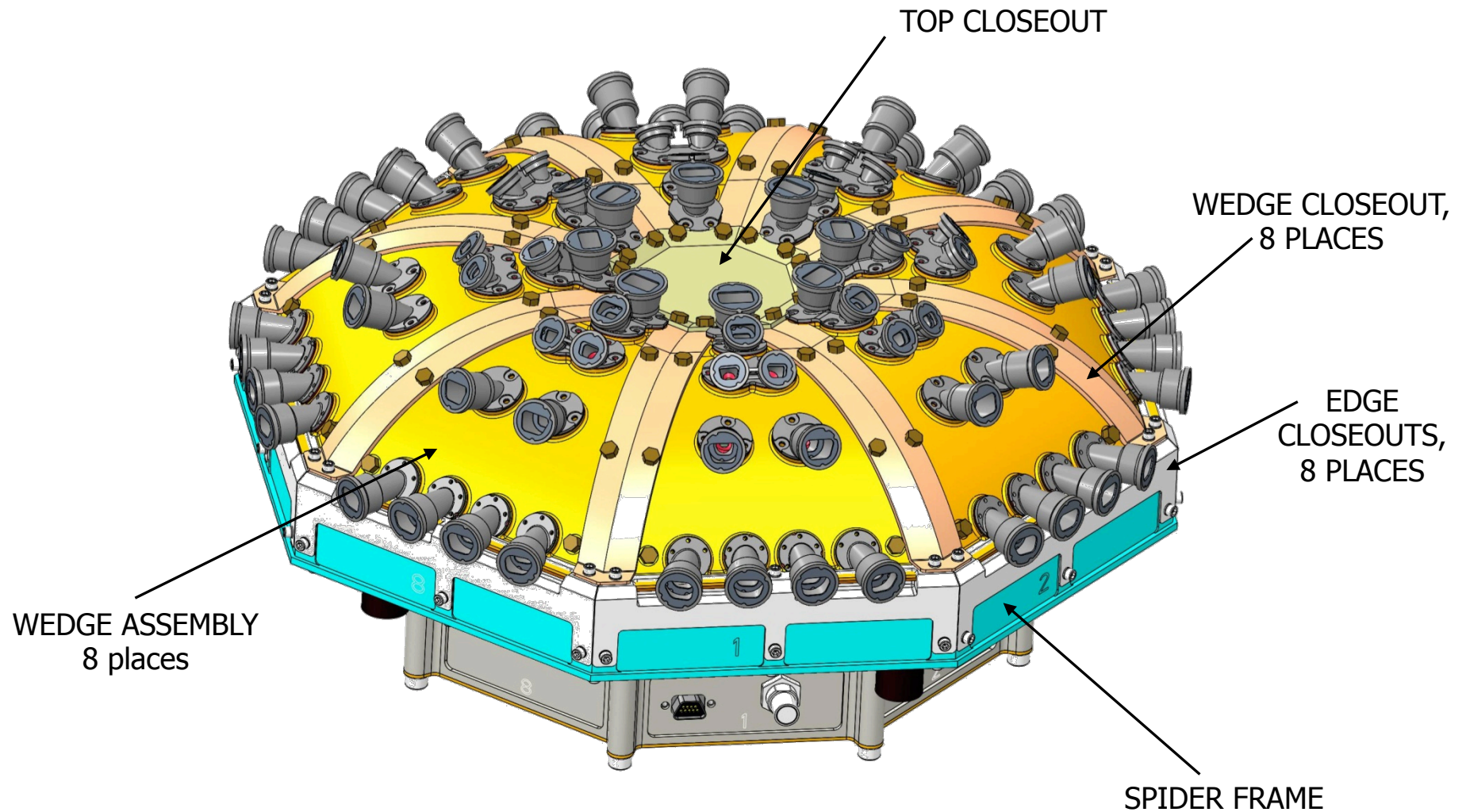
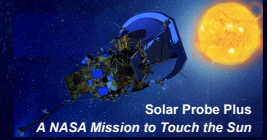
Mechanical Design Requirements



- 7434-9039, SPP Environmental Design and Test Requirements Document
 - Subsystem to have min frequency > 80 Hz
 - PWAs to have min frequency > 150 Hz
 - Quasi-static load factor: 40g (Figure 4-11 & Table 4-19)
 - Factors of safety: Table 4-5, Unpressurized Factors of Safety
 - Random vibration levels: Table 4-8 and Table 4-9
- 7464-0008 EPI-Lo-S/C Mechanical ICD
 - Generated by EPI-Lo to document placement and orientation of instrument on spacecraft



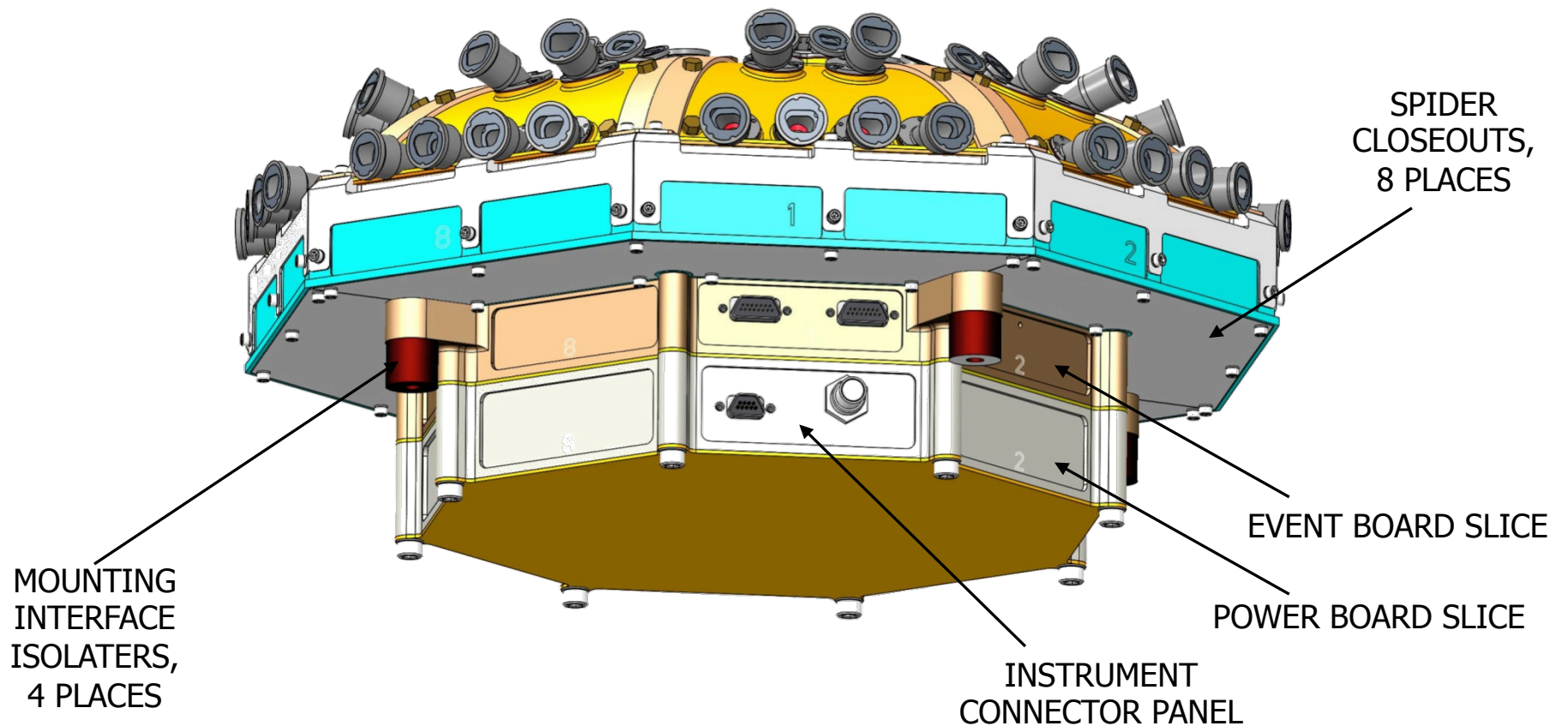
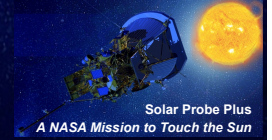
Instrument Overview



EPI-Lo Instrument Isometric View



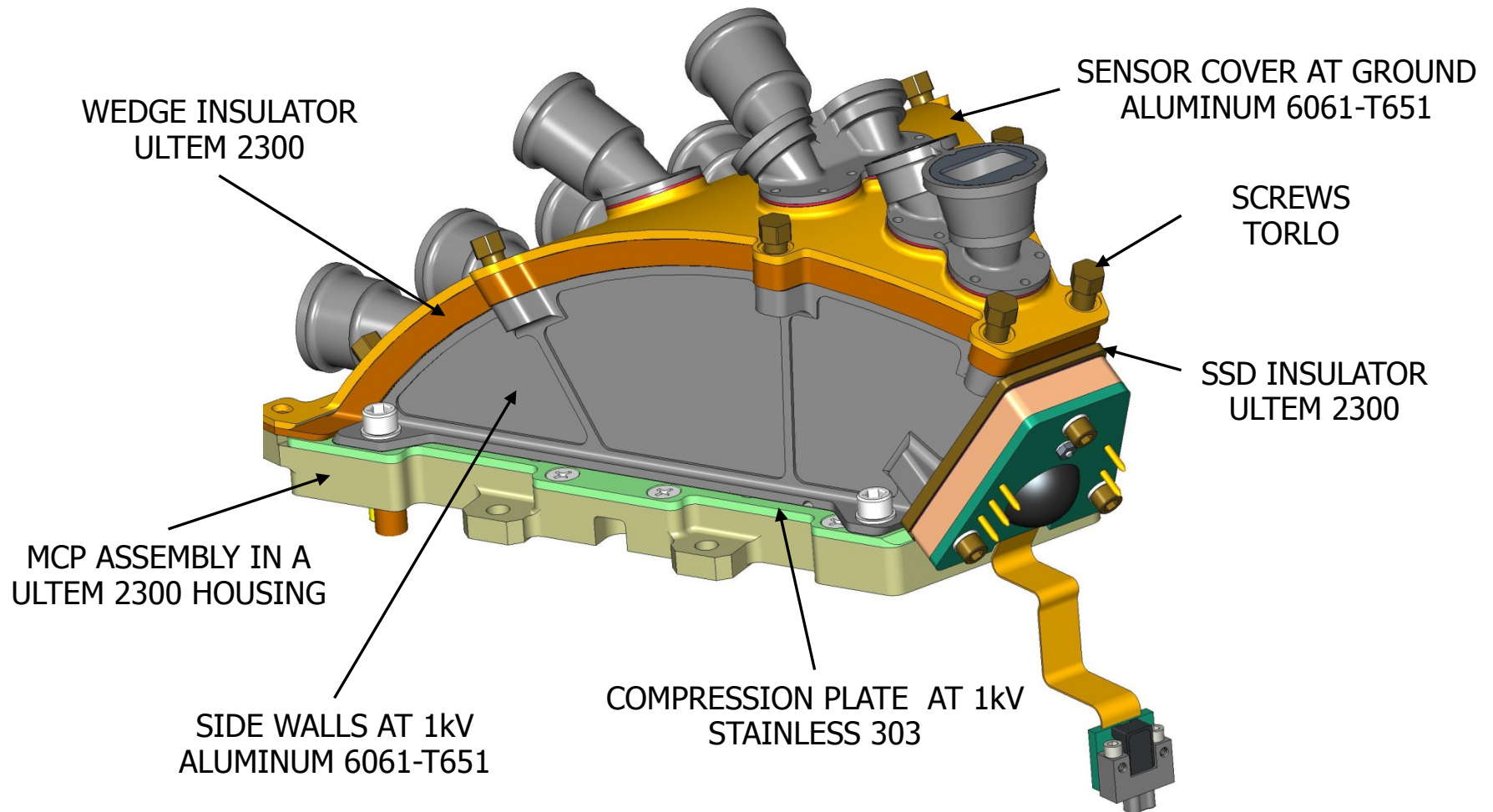
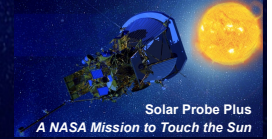
Instrument Overview



EPI-Lo Instrument Side Isometric View



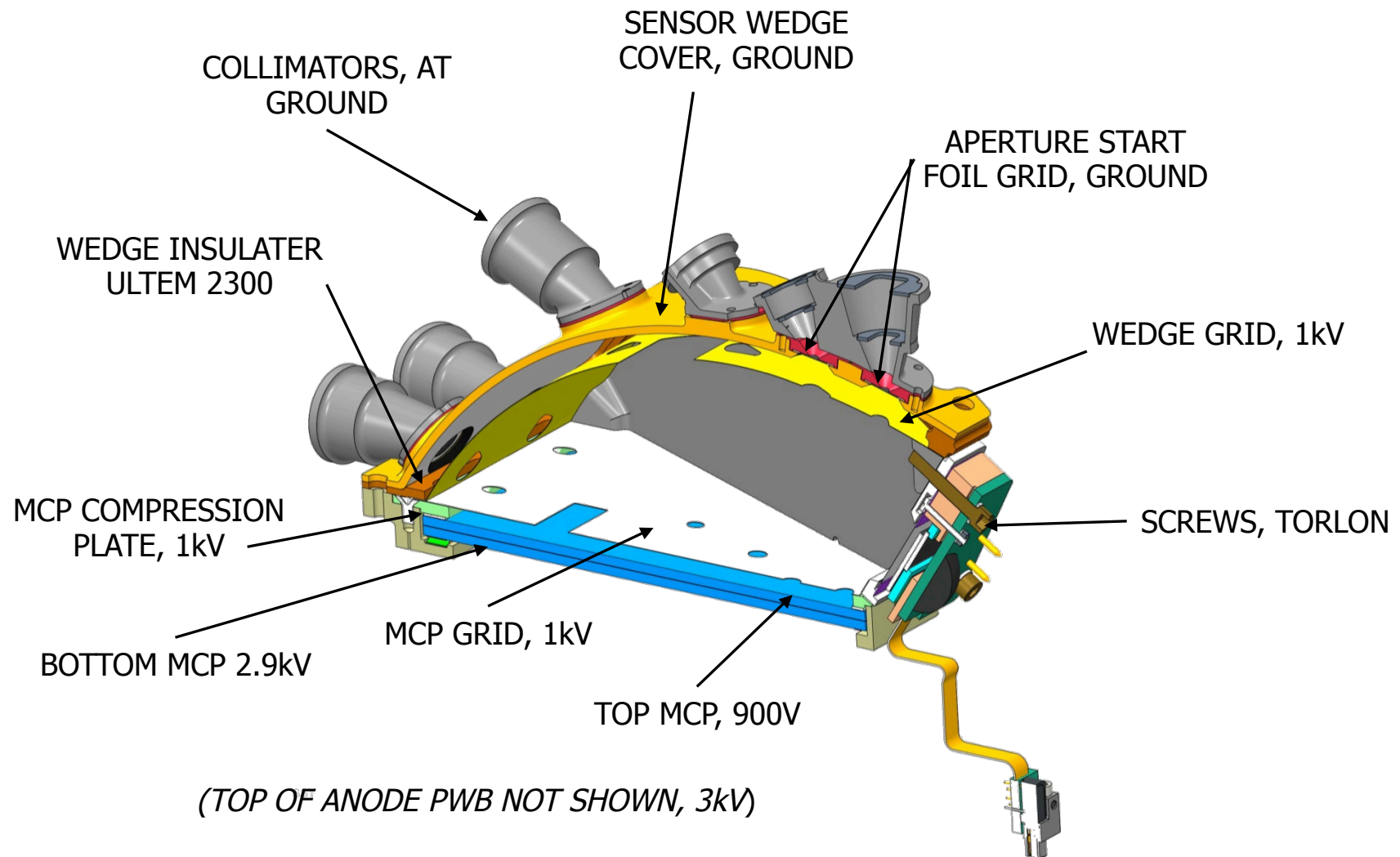
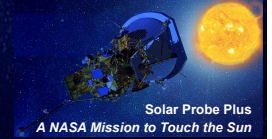
Wedge Design



EPI-Lo Sensor Wedge Assembly



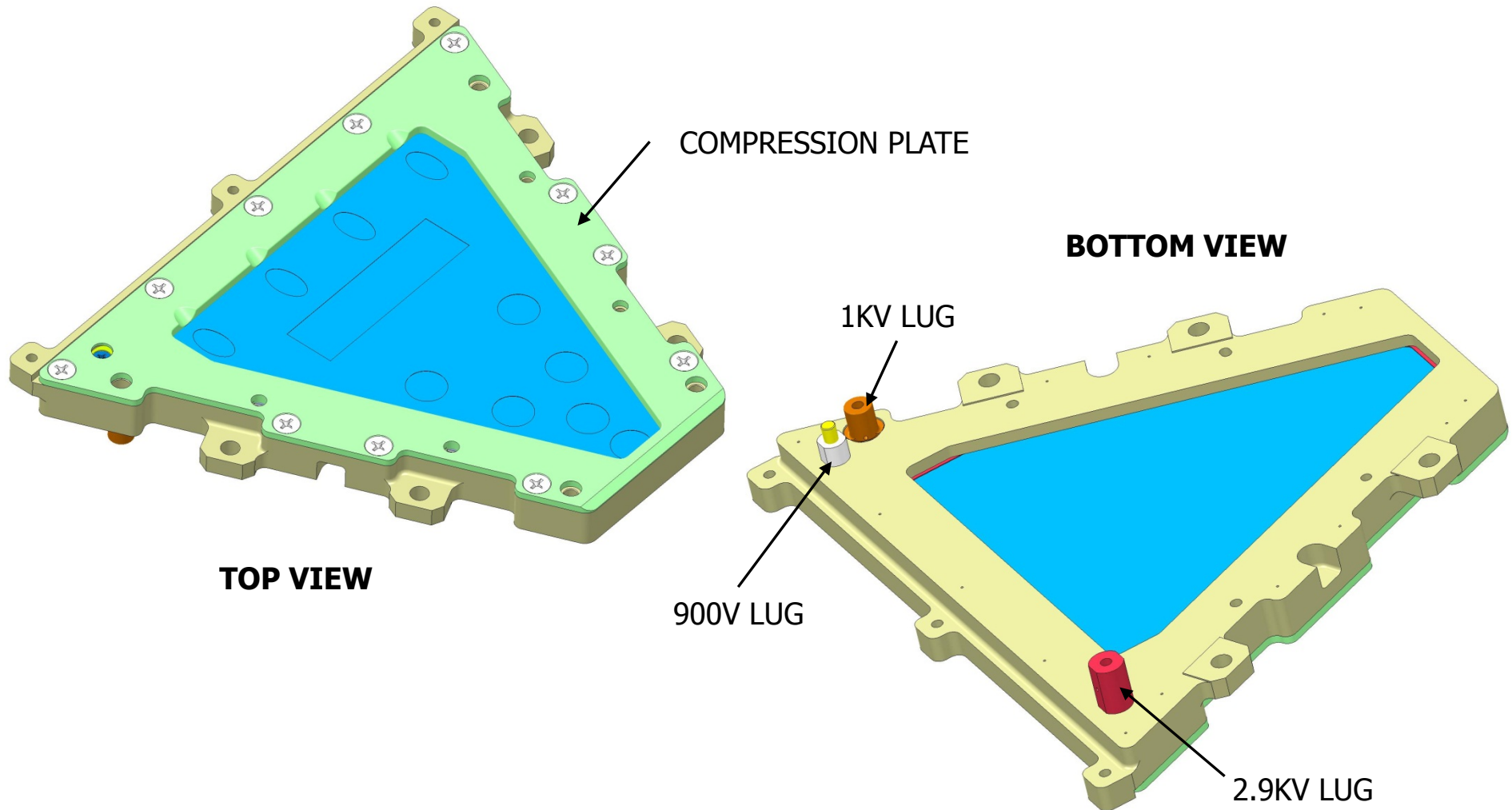
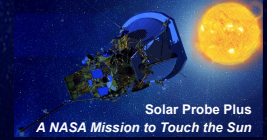
Wedge Design



EPI-Lo Sensor Wedge Assembly Cross-Section View



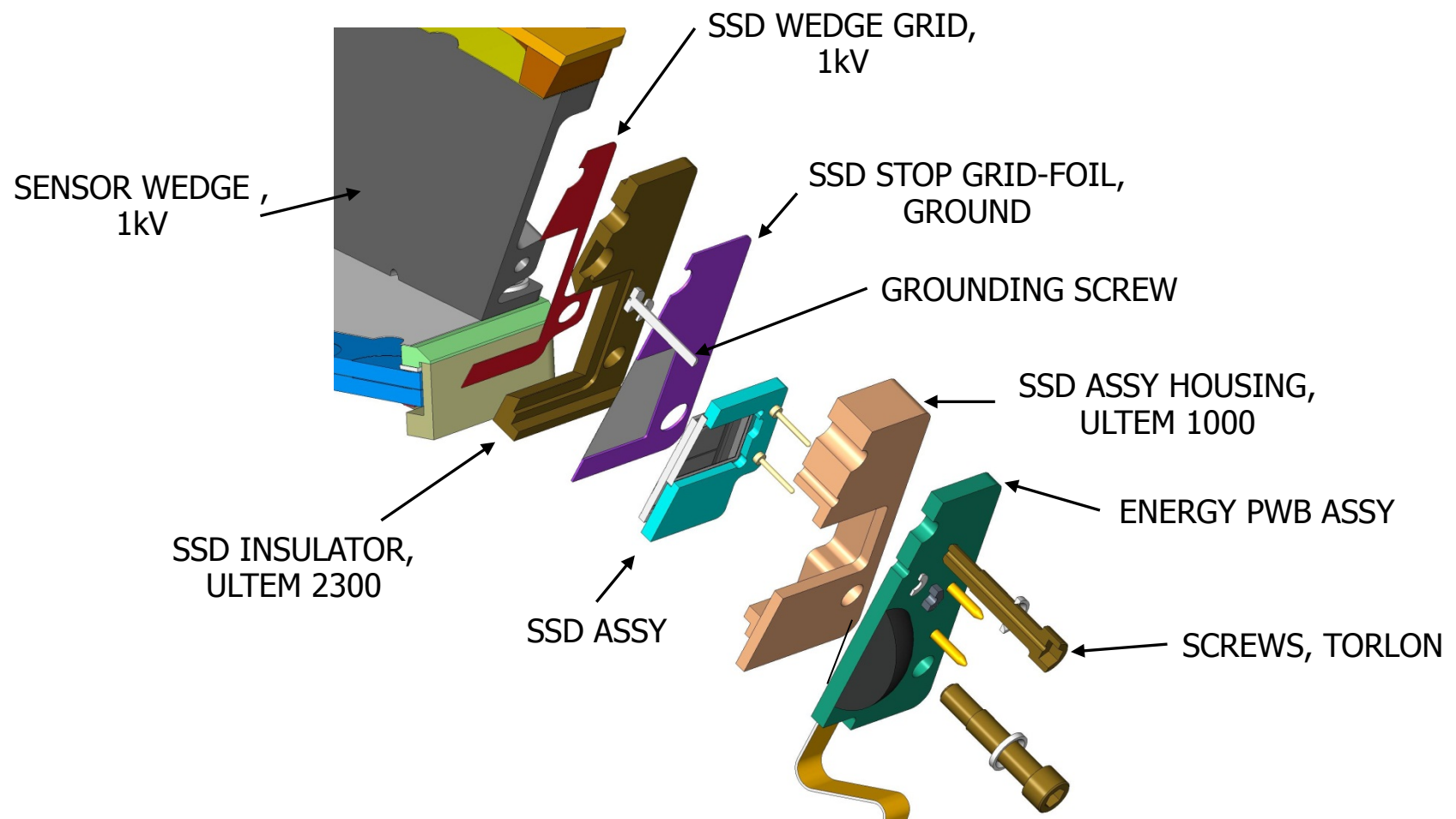
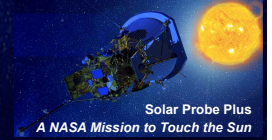
MCP Assembly Design



MCP Assembly



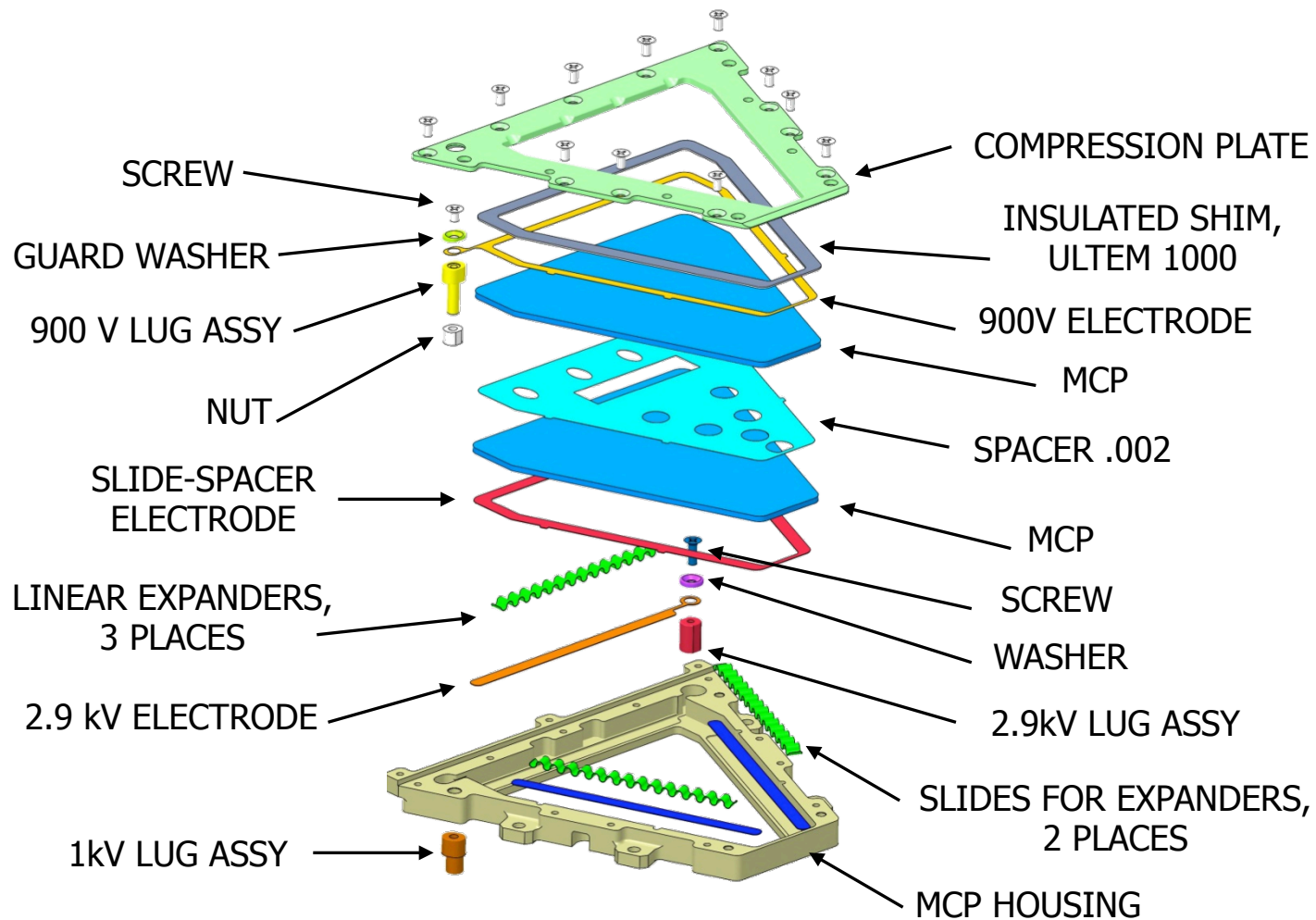
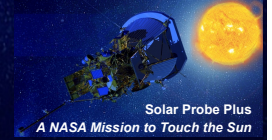
SSD Assembly Design



SSD Assembly Exploded Cross-Section View



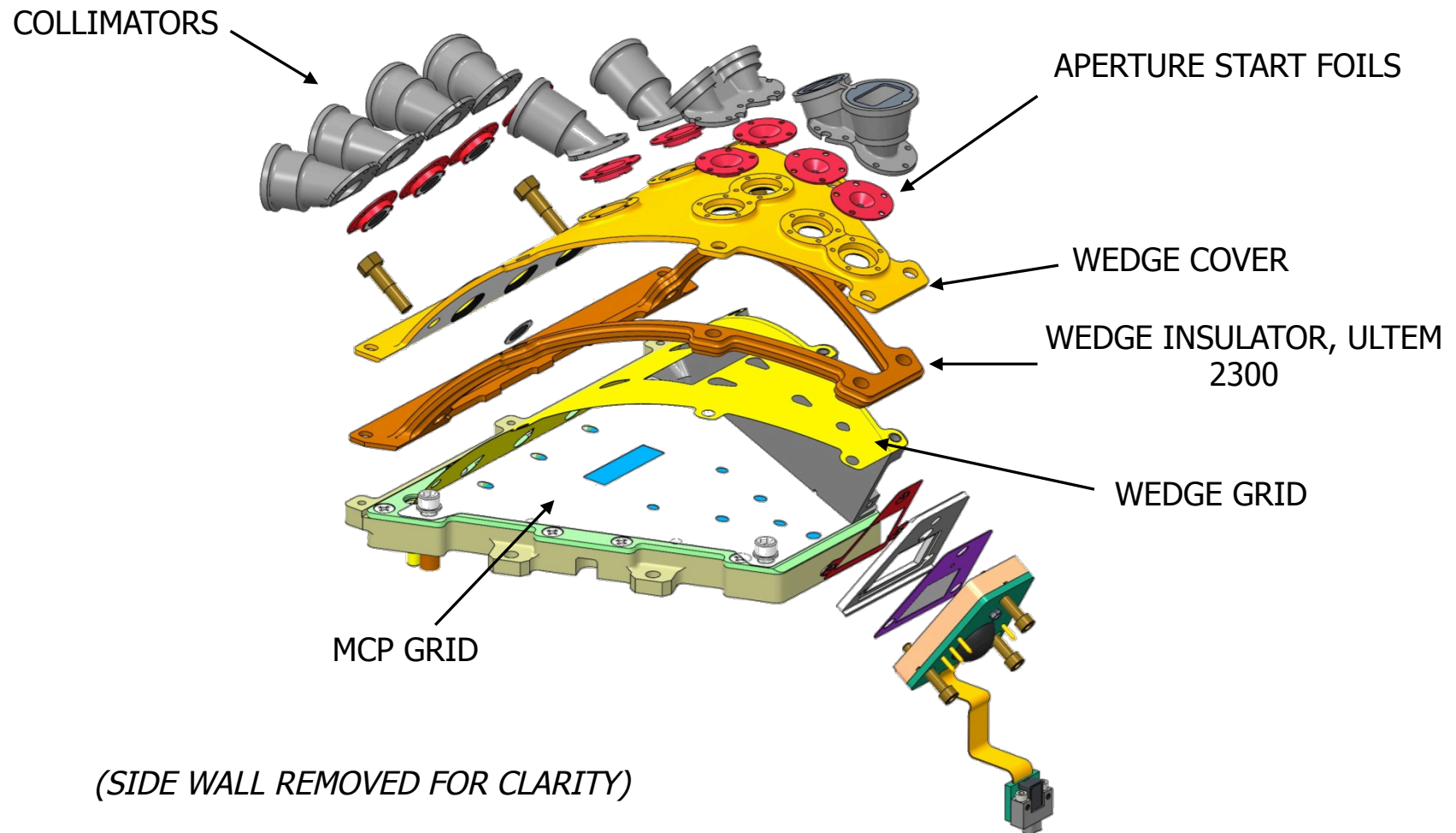
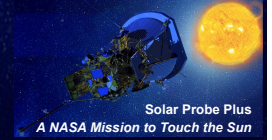
MCP Assembly Process



MCP Assembly Exploded View



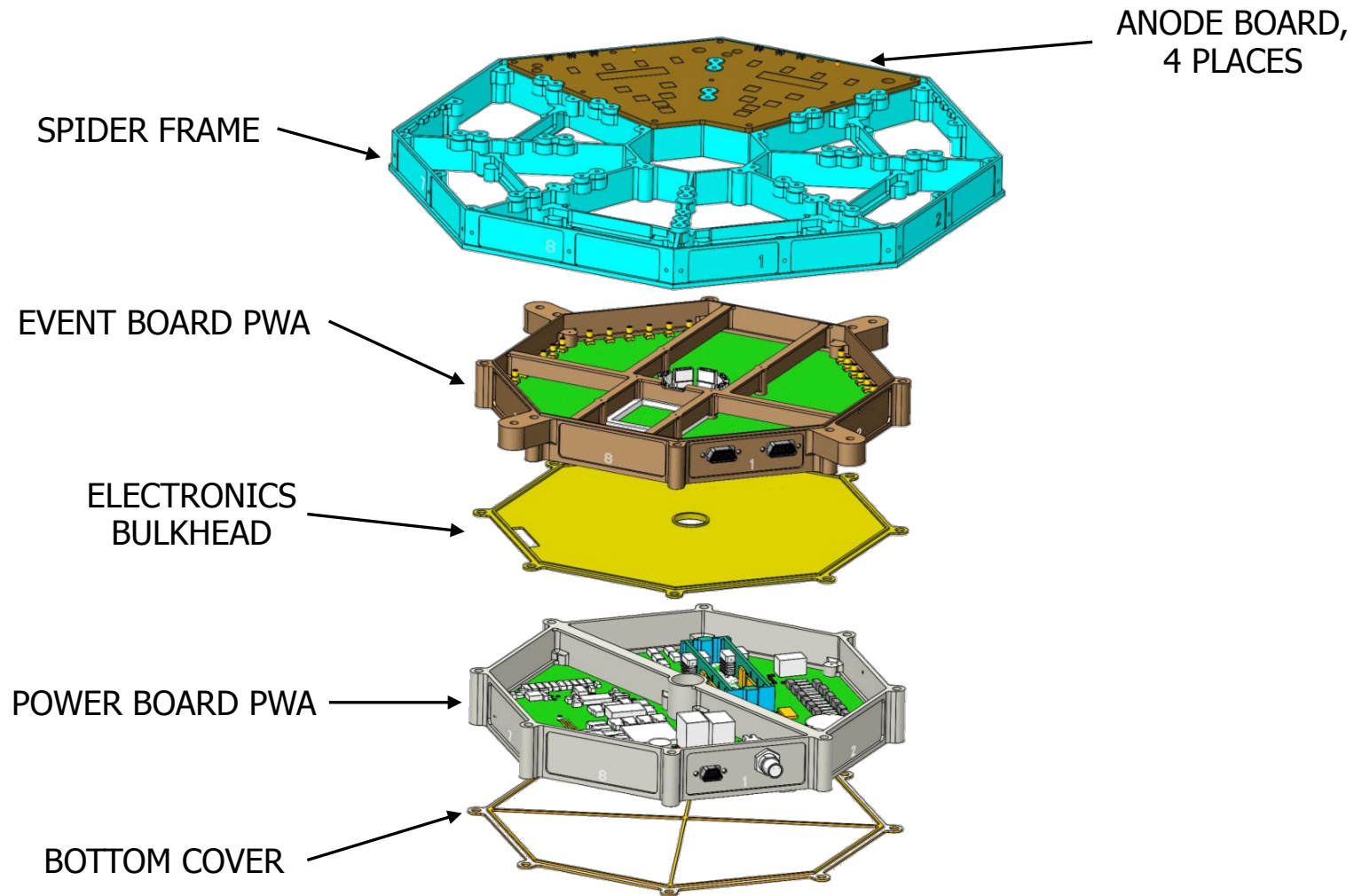
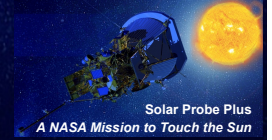
Wedge Assembly Process



EPI-Lo Sensor Wedge Assembly Exploded View



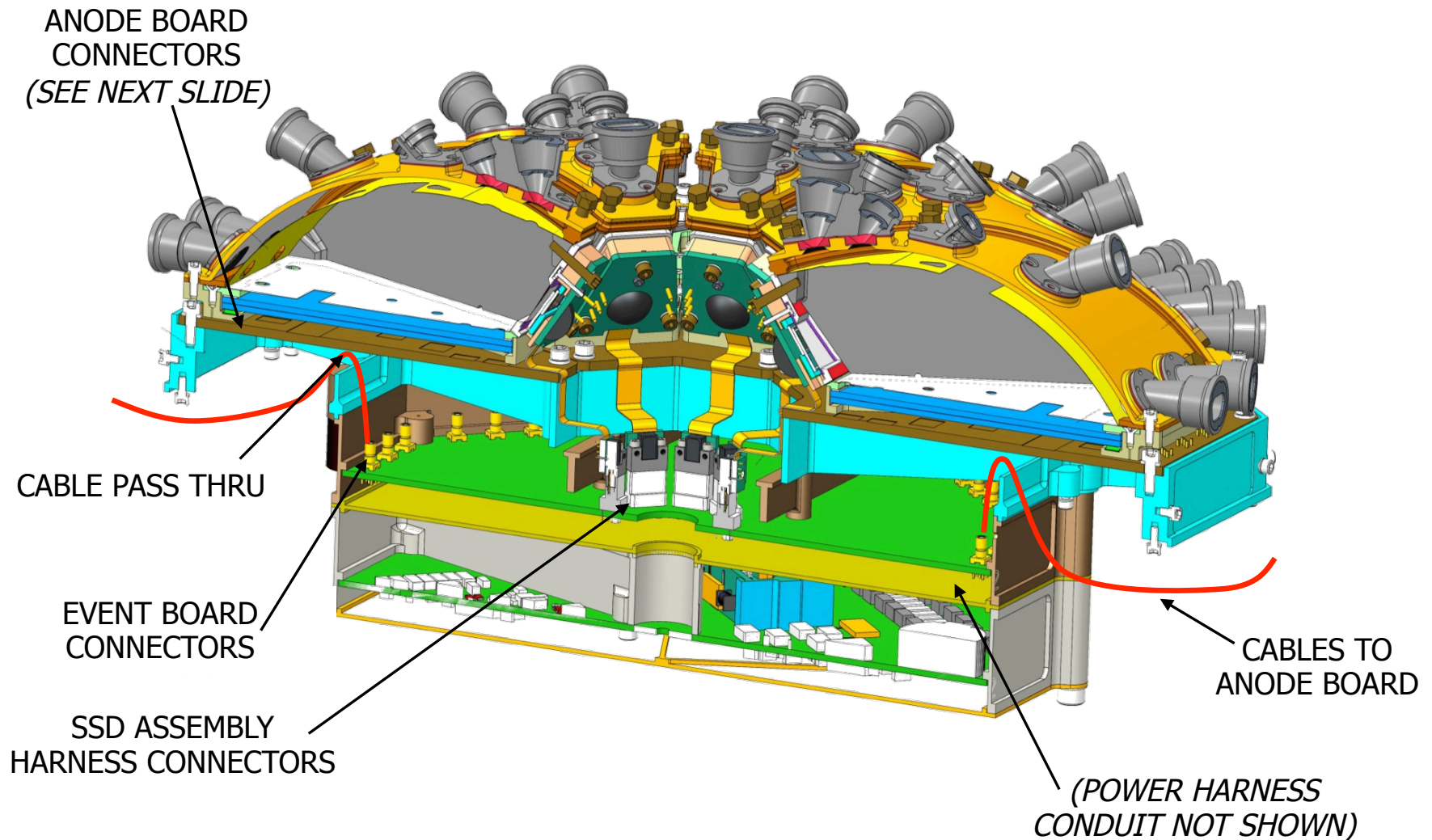
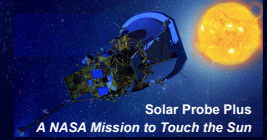
Spider and Electronics Integration



EPI-Lo Electronics Frames Exploded View



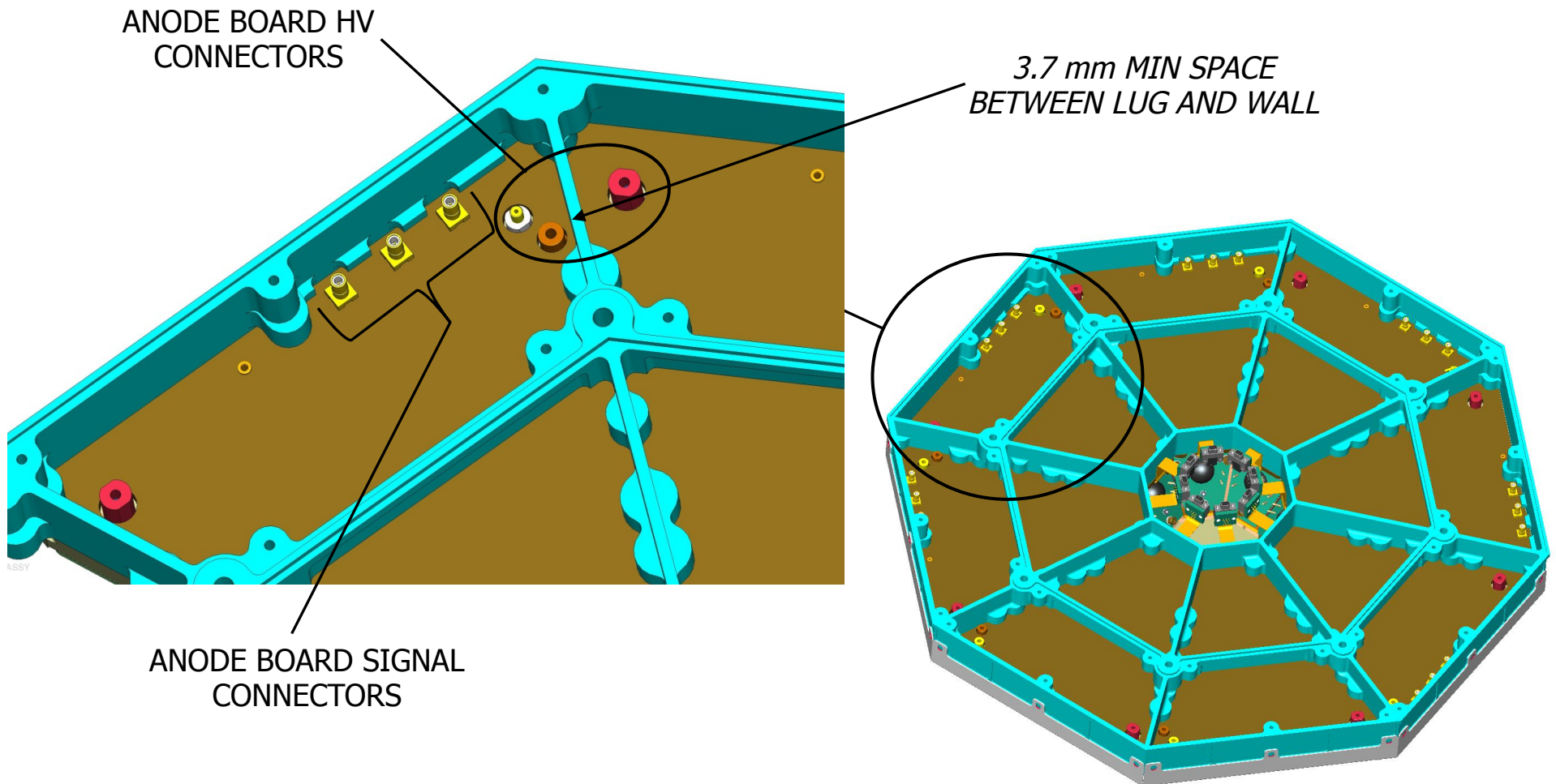
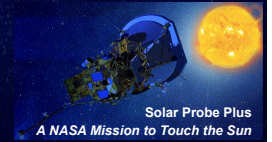
Wedge Integration and Cable Routing



EPI-Lo Cross-Section Isometric View



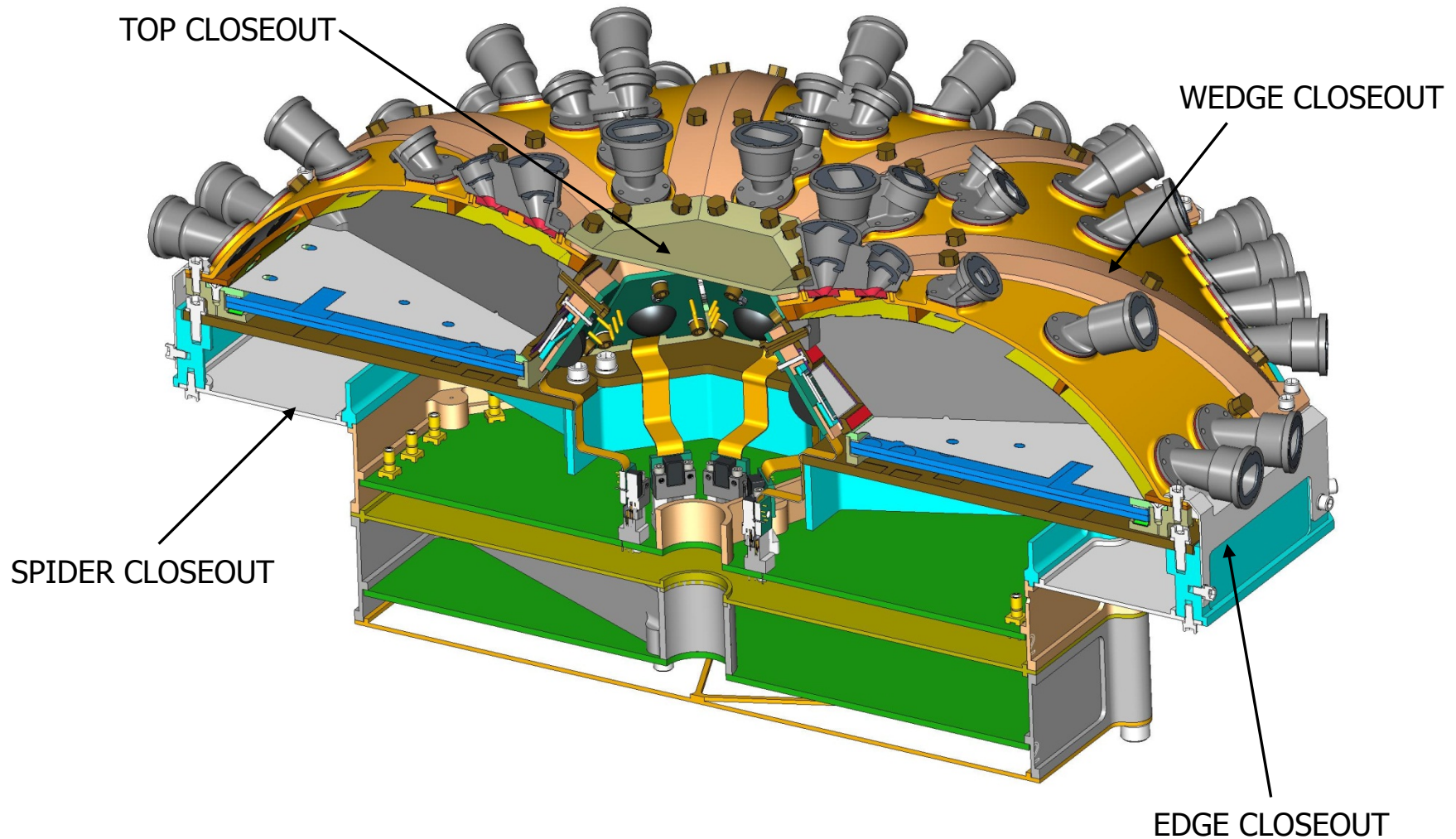
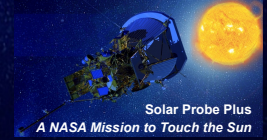
Cable Connections



**Anode PWB Assembly,
Bottom Side Shown
Mounted To Spider Frame**



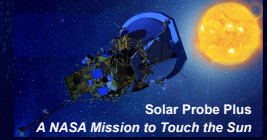
Instrument Closeout Installation



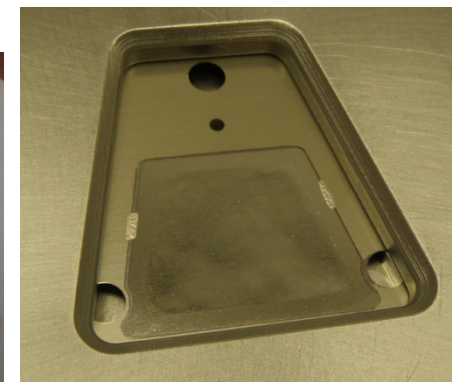
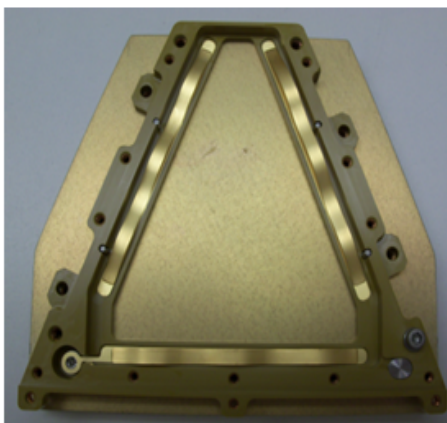
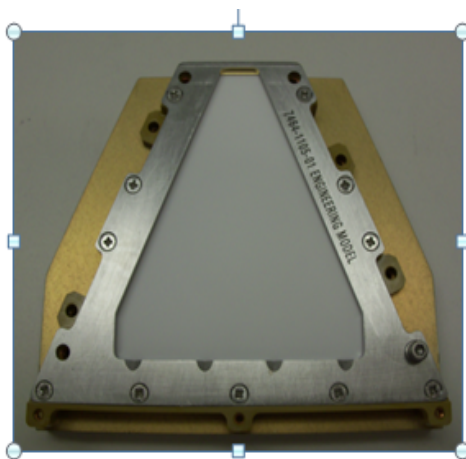
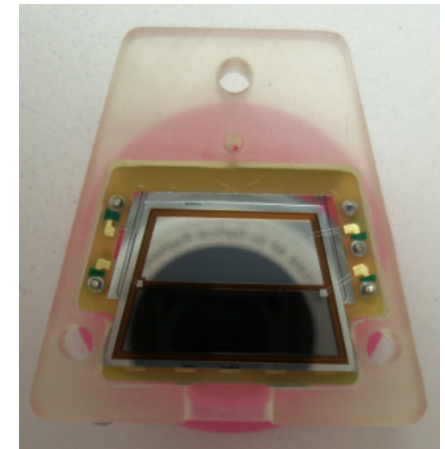
EPI-Lo Cross-Section Isometric View



Development Status

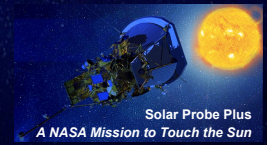


- Prototype sensor fully assembled and tested
- EM sensor
 - EM MCPs in house
 - EM SSDs in house and mounted to carrier
 - MCP holder with all electrodes assembled and tested at HV with ceramic plates
 - All EM grids and foils procured and in-house
 - Upper sensor parts in fabrication
 - Side walls, top cover, collimators





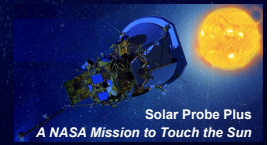
Mechanical – path forward



- Sensor EM Testing
 - Test MCP assembly with MCPs and EM anode board
 - Assemble upper sensor parts
 - Test sensor wedge
 - Start and stop secondary electron locations
 - Timing performance
 - Integrate SSD to sensor wedge
 - Full performance testing with source and in APL accelerator
- Instrument-level EM testing
 - Fabricate chassis and e-box frames
 - Vibration testing with bracket, EPI-Hi mass model, two sensor wedges and other wedges as mass models
 - Acoustics testing with bracket, EPI-Hi mass model, two sensor wedges and other wedges as mass models
 - Thermal Testing (simplified model representing outer surface)



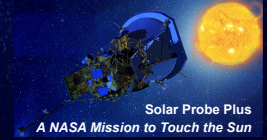
Preliminary Analysis Results



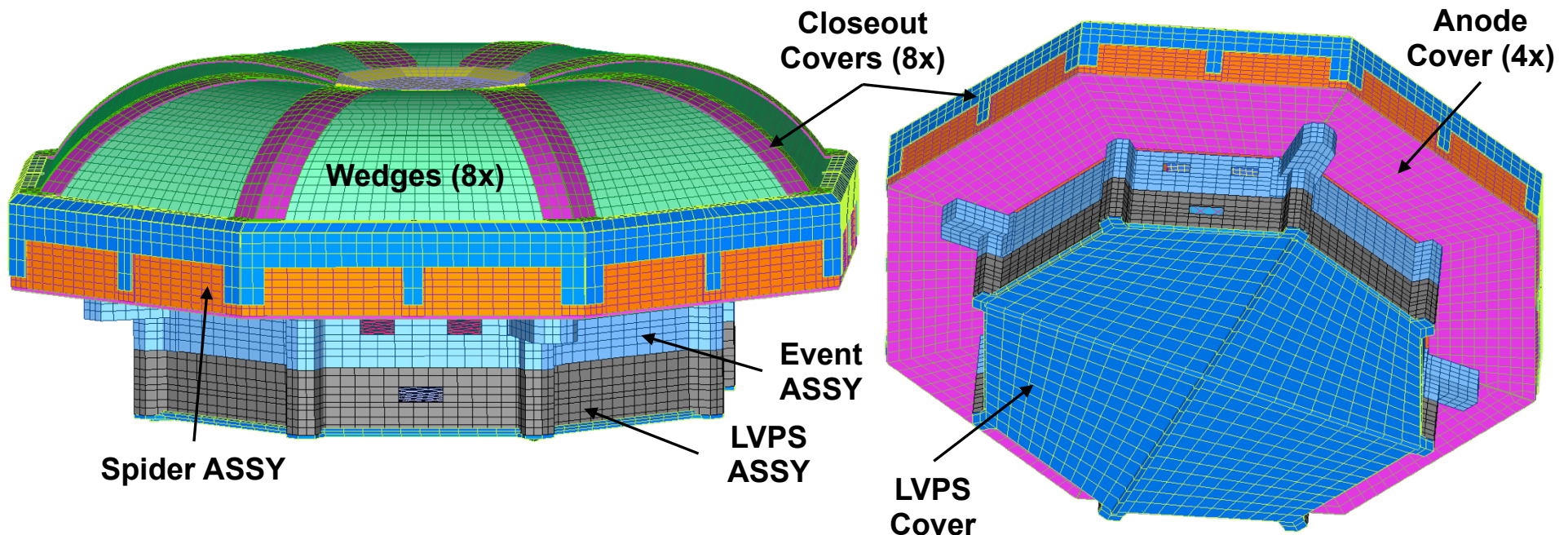
- SPP EPI-Lo instrument analyzed
 - Created from EPI-Lo CAD model as of 6/19/2013 SPP configuration
 - Instrument orientation to S/C panel taken from SwRI bracket CAD model: 4/19/2013
 - Instrument mass estimated at 2.99 kg (6.58 lbm)
- Structural model analyzed based on 7434-9039 SPP EDTRD requirements
 - Modal frequencies of assembly
 - Quasi-static design limit load per EDTRD Section 4.4.2.1 and 4.4.7.1
 - Random vibration analysis per EDTRD Section 4.4.3
 - Grms acceleration response for various components of the assembly
 - Peak 3- σ stress and displacement results



FEM Overview - Instrument Level

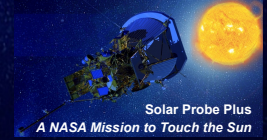


- Modeling Strategy
 - Plate elements where applicable: PWAs, frames, covers
 - Solid elements where necessary: frame bosses, bookbolt bosses, small aspect ratios
 - Beam elements: chassis ribs, LVPS bottom cover ribs
 - PWA: EEE part mass smeared over total board area
 - Rigid elements (RBE2s): bookbolts, mounting hardware, Connectors
- Model size: nodes = 89,077, elements = 70,645

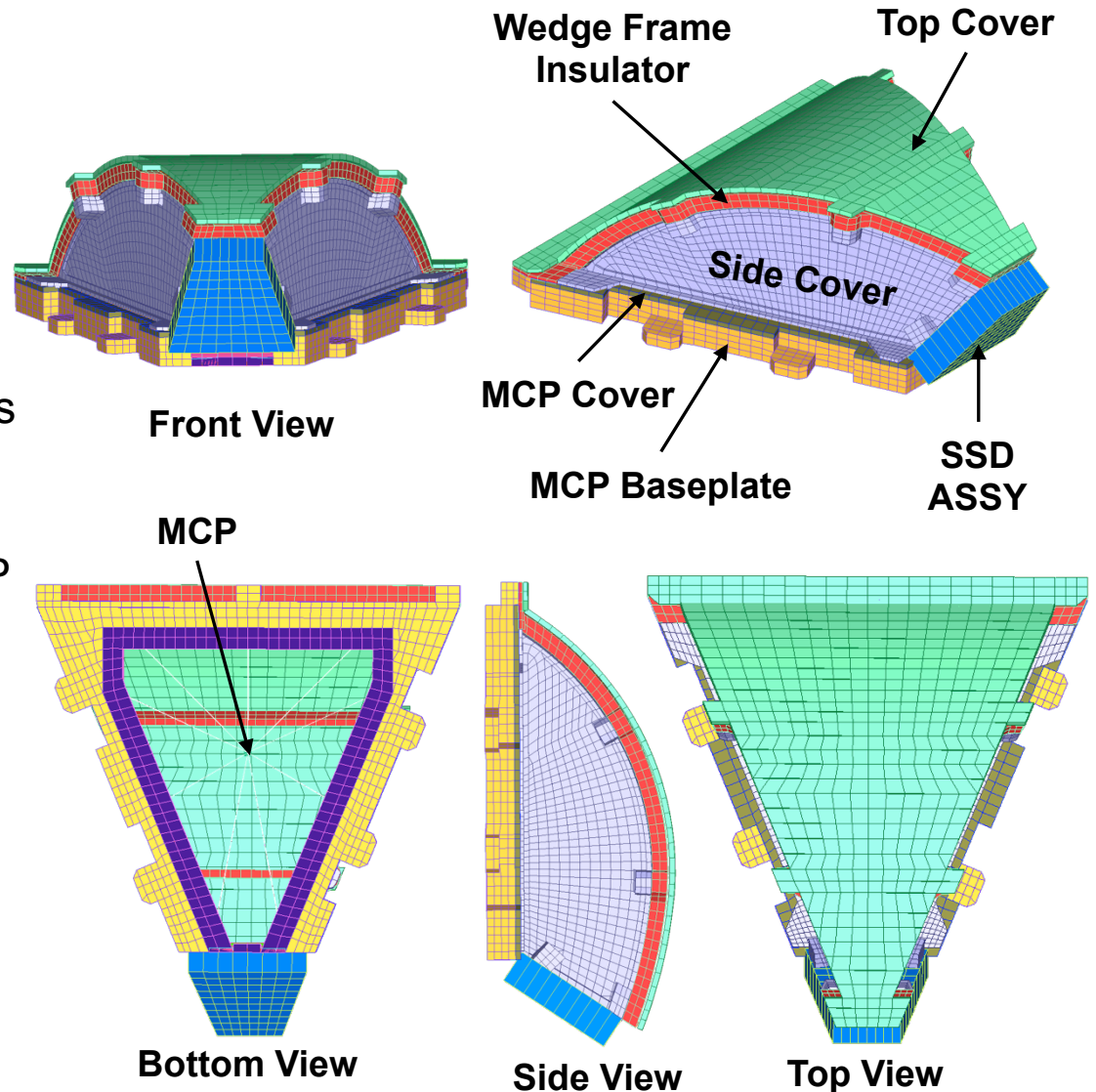




FEM Overview - Wedge Assembly

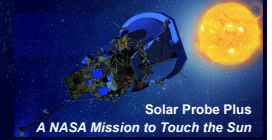


- EPI-Lo has 8 identical wedges
- Top cover: plate elements, Al-6061 properties & collimator mass smear
- Wedge Frame Insulator: plate and solid elements, Ultem1000 material properties
- Side cover: beam, plate and solid elements, Al-6061 material properties
- MCP Cover: plate elements, SS 304 properties
- MCP: mass element & RBE3 to MCP cover and baseplate
- MCP Baseplate: plate and solid elements, Ultem100 material properties
- SSD Assembly: plate elements, Ultem100 material properties
- Wedge assembly connected using RBE2s at all bolted interfaces

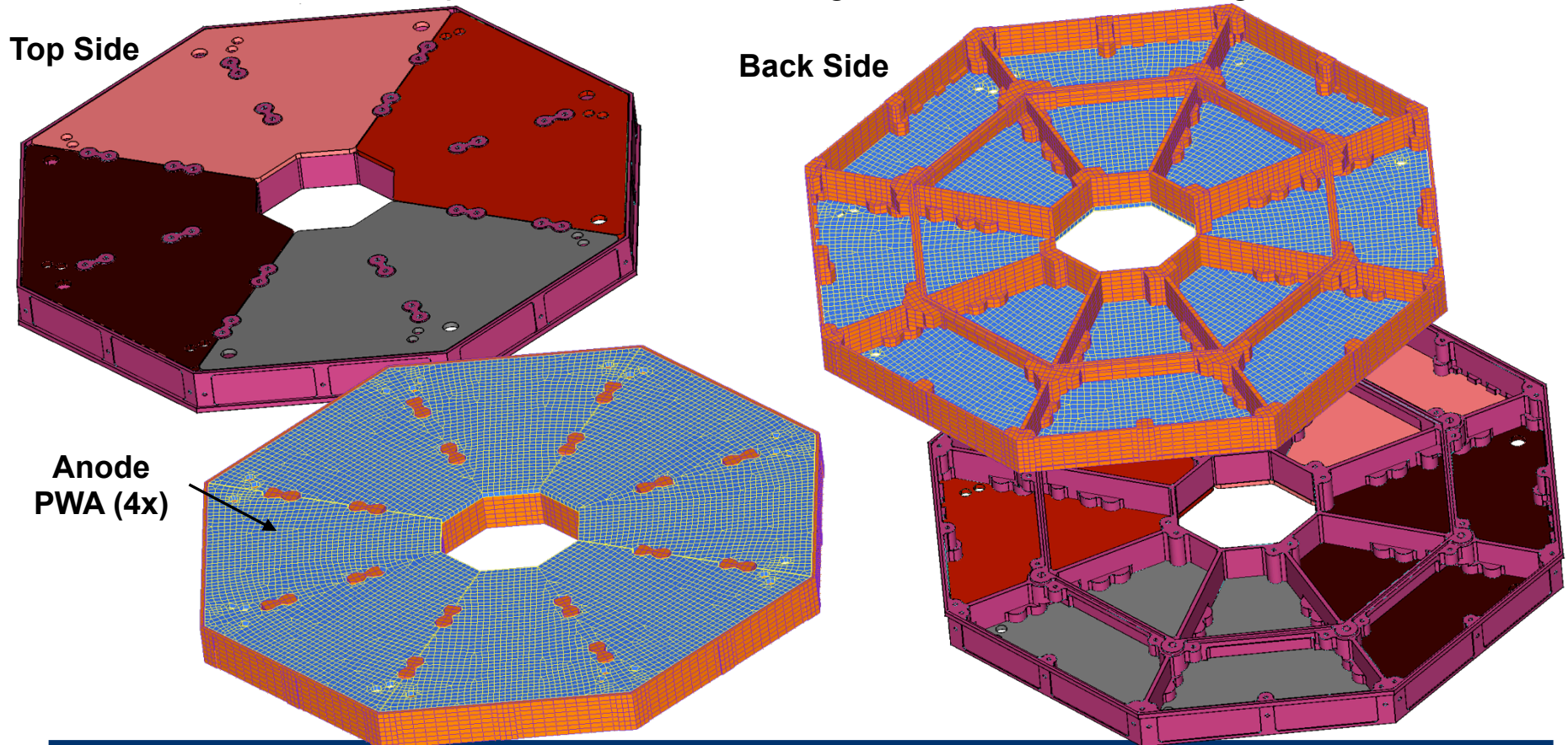




FEM Overview - Spider & Anode PWAs

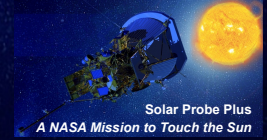


- Spider frame modeled in detail using plate and solid elements with Al 6061 material properties
- Anode PWAs (4x) modeled using plate elements and PWA material properties with estimated board mass smeared across PWA
- PWAs connected to Spider frame at mounting hardware bosses using RBE2 elements

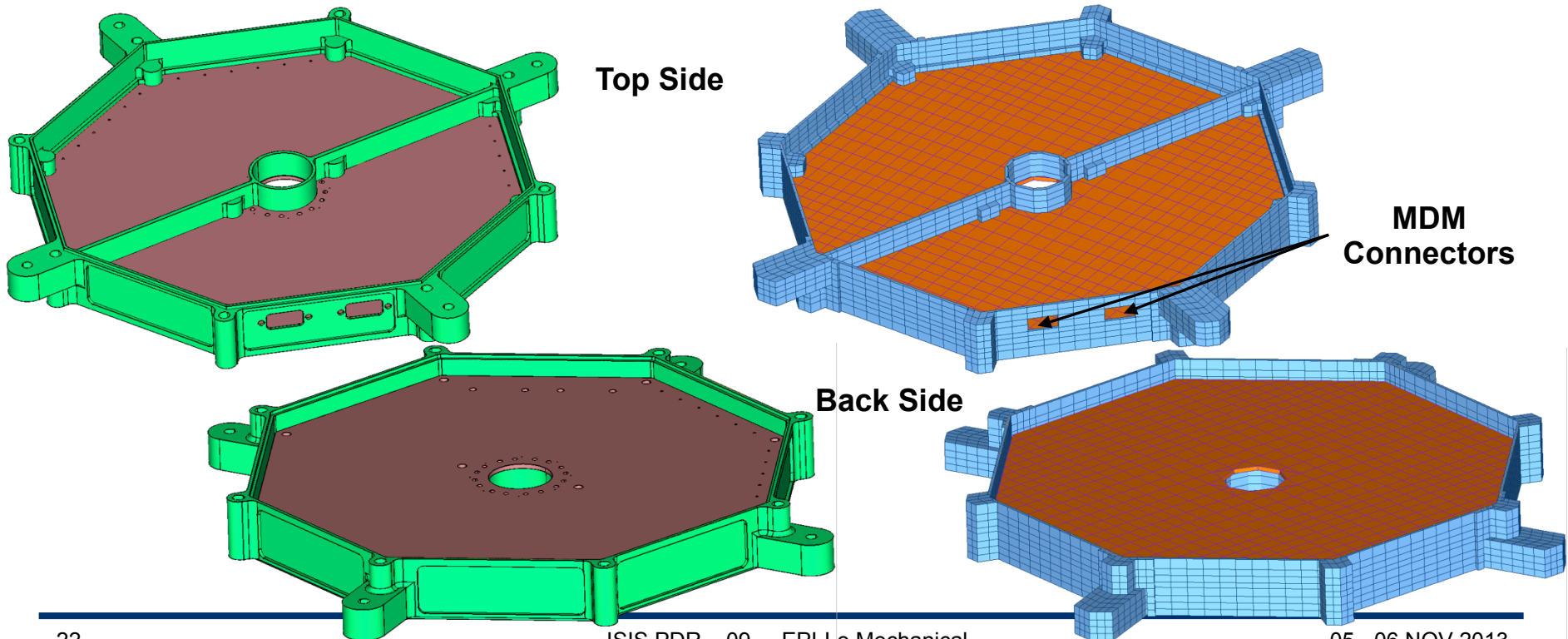




FEM Overview - Event Slice Assembly

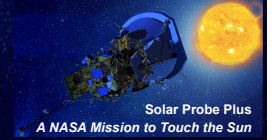


- Event housing: plate and solid elements, Al 6061 material properties
- Event housing thickness .040" at minimum, thicker at bosses
- Event PWA: plate elements, PWA material properties and EEE part mass smeared across board
- PWA: diameter = 7.0", thickness = 0.093"
- Right-angle MDM connectors modeled with RBE2s from frame to board
- PWA connected to housing with RBE2s at mounting bosses

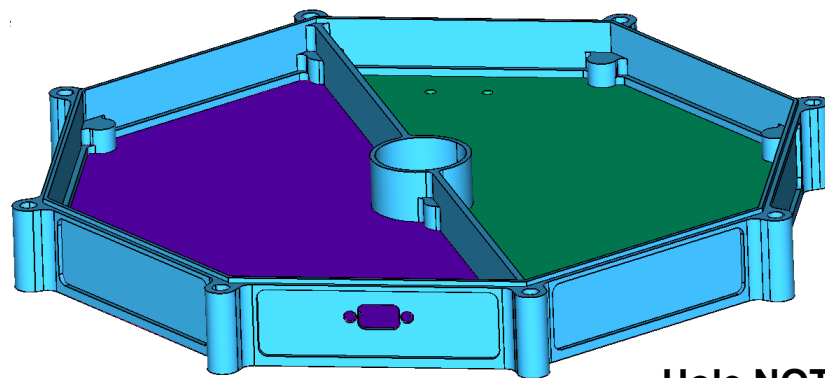




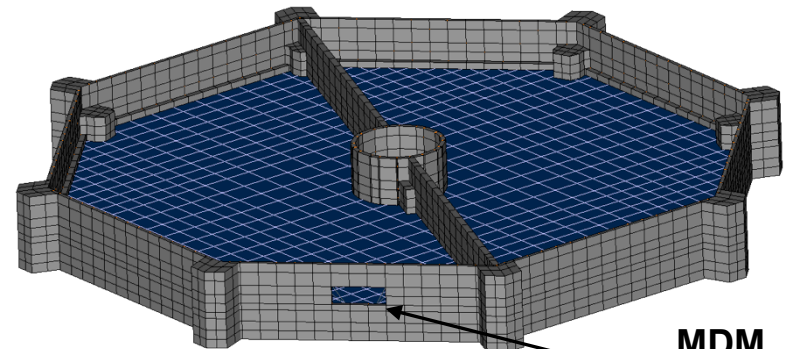
FEM Overview - LVPS Slice Assembly



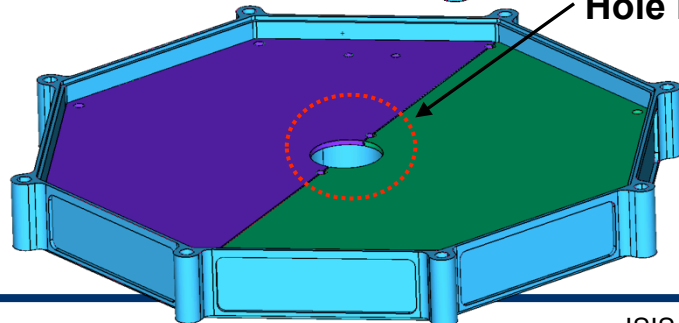
- LVPS housing: plate and solid elements, Al 6061 material properties
- LVPS housing thickness .040" at minimum, thicker at bosses
- LVPS PWA: plate elements, PWA material properties and EEE part mass smeared across board
- PWA: diameter = 7.0", thickness = 0.093"
- Right-angle MDM connector modeled with RBE2 from frame to board
- PWA connected to housing with RBE2s at mounting bosses
- CAD PWA model does not capture flight design, FEM representative of flight config.



Top Side

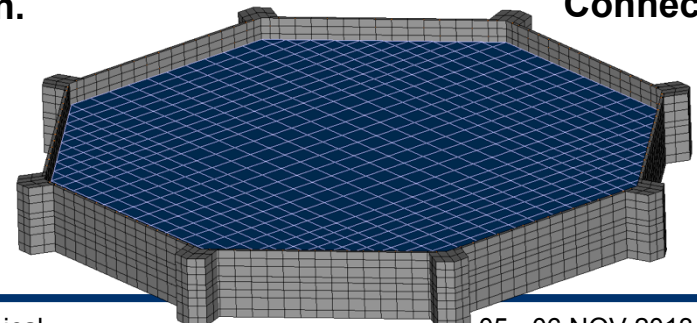


MDM Connector



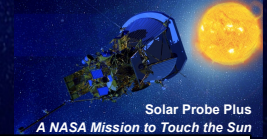
Hole NOT in flight design.

Back Side

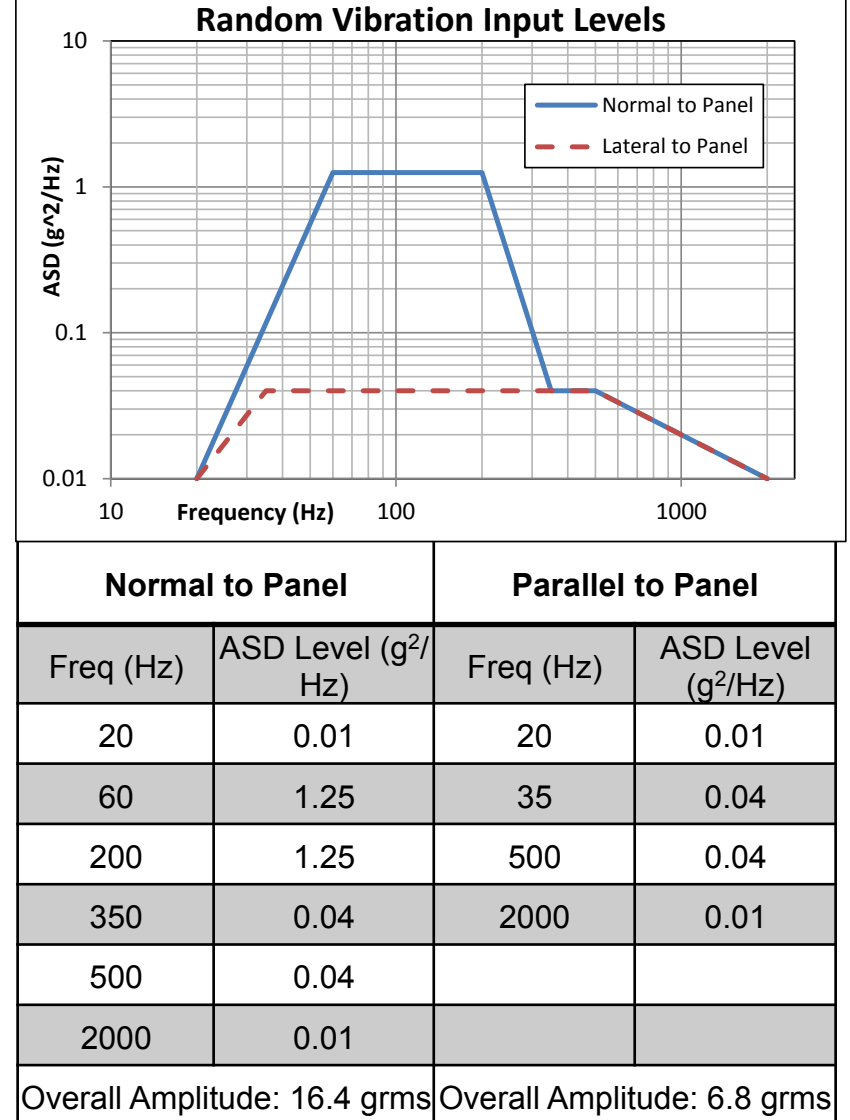




Forced Response Analysis

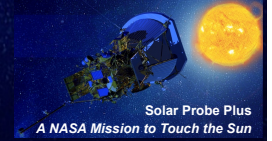


- All relevant structural environmental inputs per 7434-9039 SPP EDTD
- Assume critical damping = 2.5% across full frequency range
- Sine sweep spec per Section 4.4.4 (TBD), not analyzed
- Random vibration levels per Section 4.4.3
 - Table 4-8, Side panel mounted components & subsystems parallel to panel
 - Table 4-9, Side panel mounted components & subsystems lateral to panel
- Items of interest for random response analysis:
 - Grms acceleration response of instrument and PWAs
 - Peak 3- σ displacement response
 - Peak 3- σ stress & margins of safety
- Random vibration analysis results envelope Static 40g load (per Section 4.4.2.1),
- 40g static load results not presented in this analysis

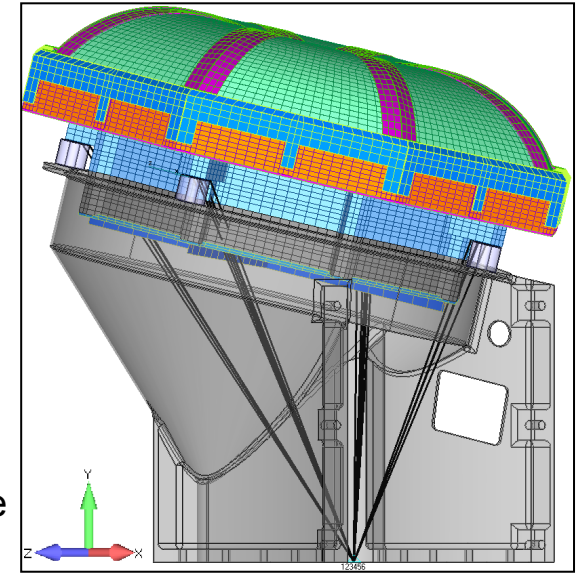




Forced Response Analysis Random Vibration Grms Results



- Random vibration inputs simulated at B.C. node
 - B.C. node “spidered” to nodes at instrument mounting interface to SwRI bracket
 - SwRI bracket and G-10 standoffs NOT part of EPI-Lo FEM, assume instrument “hard-mounted”
 - Inputs simulated one axis at a time for all three orthogonal axes
- Acceleration spectral density (ASD) response for various nodes
 - Nodes represent worst case response per subassembly
 - Across full range (20-2,000 Hz) of interest
- Due to EPI-Lo’s mounting configuration in relation to the input load, there are significant cross-axes responses



Y-axis Input 3-σ grms Response

ID	X-Axis	Y-axis	Z-Axis
Input	0.0	16.4	0.0
C.G.	7.8	67.9	8.1
Event PWA	31.2	193.0	30.1
LVPS PWA	26.4	158.1	25.1
LVPS Cover	26.9	153.5	26.2
Top Cover	16.0	112.1	17.0
Anode PWA	9.4	76.5	10.2
Anode Cover	12.2	92.3	12.8
Spider Frame	5.5	66.1	9.5

X-axis Input 3-σ grms Response

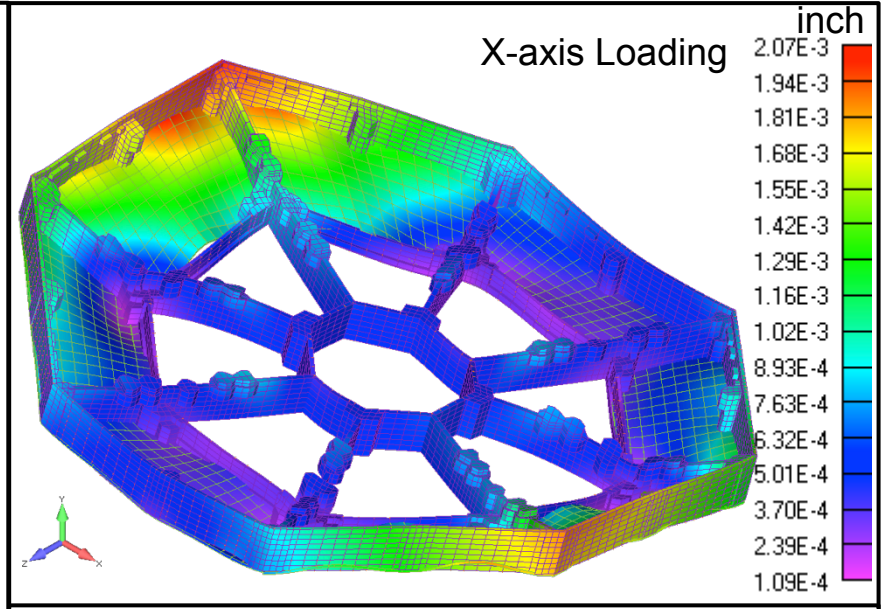
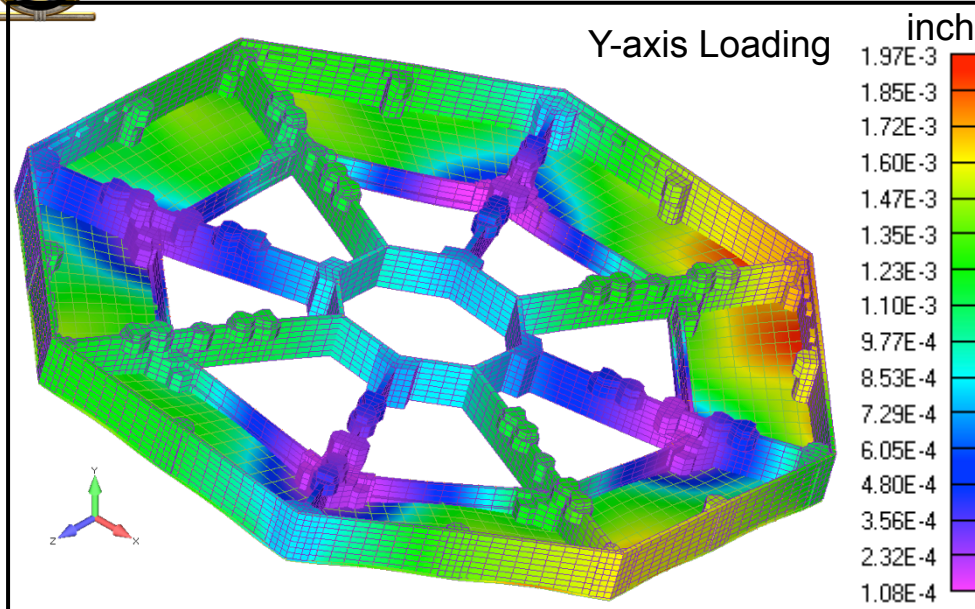
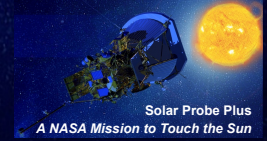
ID	X-Axis	Y-axis	Z-Axis
Input	6.8	0.0	0.0
C.G.	30.9	7.8	3.4
Event PWA	26.2	41.4	8.0
LVPS PWA	48.9	97.9	27.4
LVPS Cover	45.7	30.5	14.8
Top Cover	58.0	16.3	5.6
Anode PWA	30.8	61.5	10.3
Anode Cover	35.7	161.1	27.0
Spider Frame	29.9	64.0	12.1

Z-axis Input 3-σ grms Response

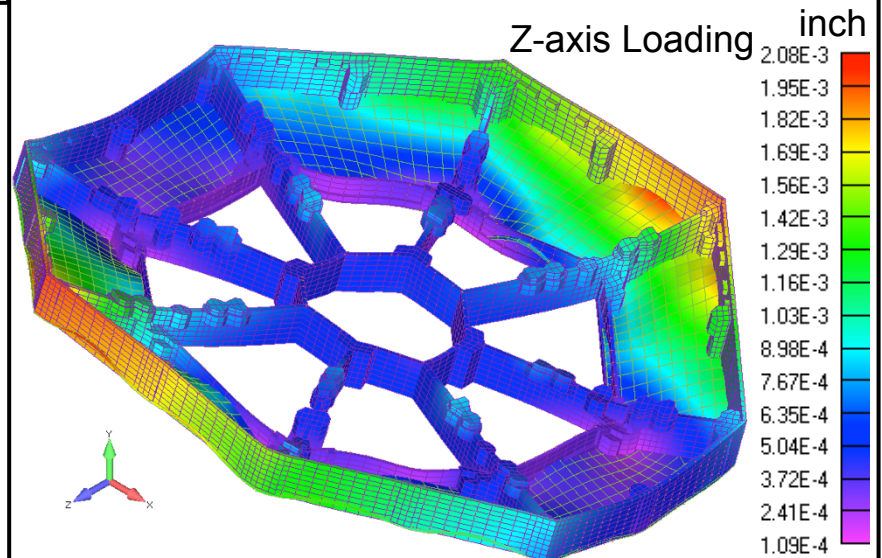
ID	X-Axis	Y-axis	Z-Axis
Input	0.0	0.0	6.8
C.G.	3.4	8.2	31.3
Event PWA	13.6	64.7	29.4
LVPS PWA	24.1	71.9	46.5
LVPS Cover	14.2	27.7	50.9
Top Cover	5.6	17.0	57.9
Anode PWA	11.8	65.4	33.9
Anode Cover	13.1	67.3	26.8
Spider Frame	8.7	28.1	31.4



Forced Response Analysis Random Vibration Results: Displacement



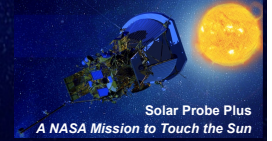
- Spider frame and Anode cover total displacement results for the 3 individual loading conditions
- Max displacement ~ 2 mil for all 3 loading conditions
- Spider frame rigid out-of-plane due to hexagonal rib design
- Anode covers stiff due to 9 mounting holes, all corners and mid-span





Forced Response Analysis

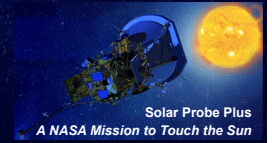
Random Vibration Results: von Mises Stress



- Model analyzed for von Mises stress under random vibration loading using MAYA structural analysis toolkit
- 3- σ stress results output for complete model
- Interested mainly in PWA and Frame stress
- Fastener analysis not done at this time
- Factors of safety (FoS) taken from 7434-9039 SPP EDTRD rev e, table 4-5.
 - Additional 1.28 factor for random analysis per Section 4.4.2.2
 - Metallic structures: FoSu = 2.68, FoSy = 2.53
 - Composite (PWA + Ultem1000): FoSu = 2.78, FoSy = N/A
- Margins of safety (MoS) calculations performed,
 - MoS formula ->
$$MoS = \frac{Strength}{FoS * \sigma} - 1$$
 - MoS table on the following slide
- All margin of safety results are positive for the current design iteration



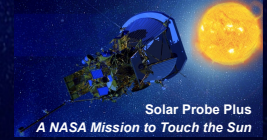
Analysis Summary



- Preliminary structural analysis of the baseline SPP EPI-Lo Instrument performed
- MSC.Nastran, MAYA SATK, and Femap used for analysis
 - Model simplified wherever possible to aid solution time
 - PWAs modeled as plate elements with uniform stiffness, thickness and density
 - Instrument model oriented to SwRI bracket configuration in relation to S/C panel
- Modal analysis performed, 1st mode = 304 Hz (Event PWA), Instrument mode #1 = 553 Hz
- Analysis environmental input levels per 7434-9039 SPP EDTRD Rev -
 - Analysis performed for all three orthogonal axes relative to S/C panel
 - Sine vibration analysis not performed (TBD in EDTRD)
 - EPI-Lo 3- σ acceleration random response enveloped static load requirement
 - Random vibration analysis 3- σ response desired for EPI-Lo instrument displacements, stresses and forces
- Random vibration PWA displacement response may be relatively high for EEE part solder/lead wire fatigue resistance, further analysis needed after EEE parts placement finalized
- All margin of safety positive for model configuration as of 6/19/13 under EDTRD Rev - inputs
- Detailed analysis needed for the flight configuration to confirm flight design will have positive margins and meet minimum frequency requirement



Instrument Peer Review



- EPI-Lo Sensor Peer Review
 - Held May 22, 2013 at APL
 - Review yielded 12 action items, all are now closed

- EPI-Lo Instrument Peer Review
 - Held August 19, 2013 at APL
 - Review yielded 8 mechanical action items, all are now closed



Backup

